

<b>Search Notes</b>  <b>*1069605</b> <b>1*</b>	<b>Application/Control No.</b> 10696051	<b>Applicant(s)/Patent Under Reexamination</b> CHEN, SU
	<b>Examiner</b> Weisz, David G	<b>Art Unit</b> 1797

<b>SEARCHED</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
436	127,129,173 (text limited)	12/17/2010	/DW/

<b>SEARCH NOTES</b>			
<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>	
Updated EAST text search (see search history), Updated Google text search (18O, internal standard, organic acid), Inventor search in PALM	4/7/2010	/DW/	

<b>INTERFERENCE SEARCH</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>

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